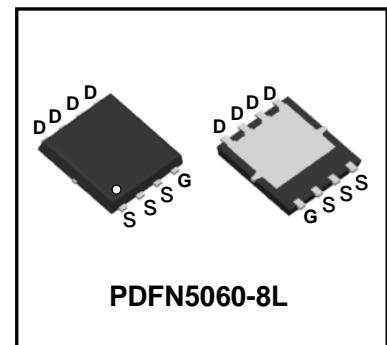


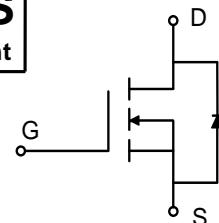
200V N-Channel Enhancement Mode Power MOSFET

Description

WMB340N20HG2 uses Wayon's 2nd generation power trench MOSFET technology that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance. This device is well suited for high efficiency fast switching applications.

**Features**

- $V_{DS} = 200V$, $I_D = 40A$
 $R_{DS(on)} < 34m\Omega$ @ $V_{GS} = 10V$
- High Speed Power Switching
- 100% EAS Guaranteed
- Low Gate Charge

**Applications**

- Synchronous Rectification in SMPS
- Hard Switching and High Speed Circuit
- UPS
- Motor Control
- Power Tools

Absolute Maximum Ratings ($T_A = 25^\circ C$, unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	200	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current $T_C=25^\circ C$	I_D	40	A
$T_C=100^\circ C$		25	
Pulsed Drain Current ¹	I_{DM}	160	A
Single Pulse Avalanche Energy ²	EAS	96.8	mJ
Total Power Dissipation $T_C=25^\circ C$	P_D	108.6	W
Operating Junction and Storage Temperature Range	T_J , T_{STG}	-55 to 150	$^\circ C$

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction-to-Ambient ³	$R_{\theta JA}$	56	$^\circ C/W$
Thermal Resistance from Junction-to-Case	$R_{\theta JC}$	1.15	$^\circ C/W$

Electrical Characteristics (T_J = 25°C, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	200	-	-	V
Gate-Body Leakage Current	I _{GS}	V _{DS} = 0V, V _{GS} = ±20V	-	-	±100	nA
Zero Gate Voltage Drain Current T _J =25°C	I _{DSS}	V _{DS} = 200V, V _{GS} = 0V	-	-	1	μA
T _J =100°C			-	-	100	
Gate-Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	2	3	4	V
Drain-Source on-Resistance ⁴	R _{DS(on)}	V _{GS} = 10V, I _D = 8A	-	27	34	mΩ
Forward Transconductance ⁴	g _f	V _{DS} = 5V, I _D = 10A	-	32	-	S
Dynamic Characteristics⁵						
Input Capacitance	C _{iss}	V _{DS} = 100V, V _{GS} = 0V, f = 1MHz	-	1702	-	pF
Output Capacitance	C _{oss}		-	141	-	
Reverse Transfer Capacitance	C _{rss}		-	8.5	-	
Gate Resistance	R _G	f = 1MHz	-	3.5	-	Ω
Switching Characteristics⁵						
Total Gate Charge	Q _g	V _{GS} = 10V, V _{DS} = 100V, I _D = 10A	-	23	-	nC
Gate-Source Charge	Q _{gs}		-	8.2	-	
Gate-Drain Charge	Q _{gd}		-	2.4	-	
Turn-on Delay Time	t _{d(on)}	V _{GS} = 10V, V _{DD} = 100V, R _G = 10Ω, I _D = 10A	-	14.5	-	ns
Rise Time	t _r		-	20	-	
Turn-off Delay Time	t _{d(off)}		-	26	-	
Fall Time	t _f		-	12.5	-	
Body Diode Reverse Recovery Time	t _{rr}	I _F = 10A, dI/dt = 100A/μs	-	85	-	ns
Body Diode Reverse Recovery Charge	Q _{rr}		-	300	-	nC
Drain-Source Body Diode Characteristics						
Diode Forward Voltage ⁴	V _{SD}	I _S = 1A, V _{GS} = 0V	-	-	1.2	V
Continuous Source Current T _C =25°C	I _S	-	-	-	40	A

Notes:

1. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C.
2. The test condition is V_{DD}=25V, V_{GS}=10V, L=0.4mH, I_{AS}=22A.
3. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
4. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
5. This value is guaranteed by design hence it is not included in the production test.

Typical Characteristics

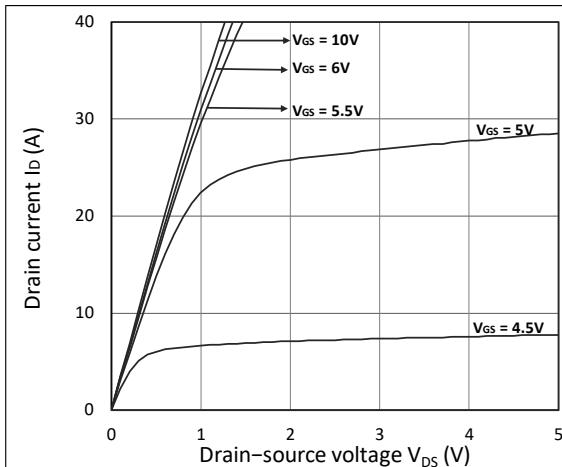


Figure 1. Output Characteristics

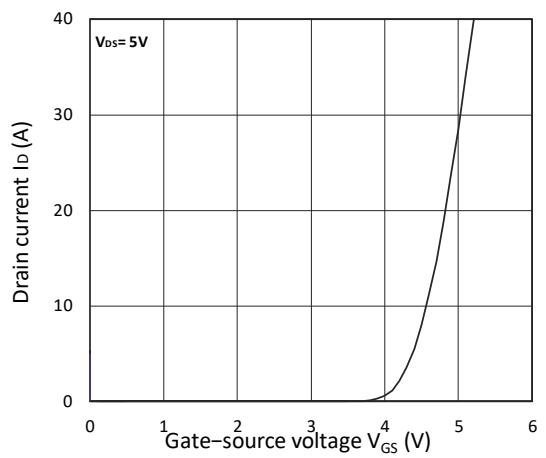


Figure 2. Transfer Characteristics

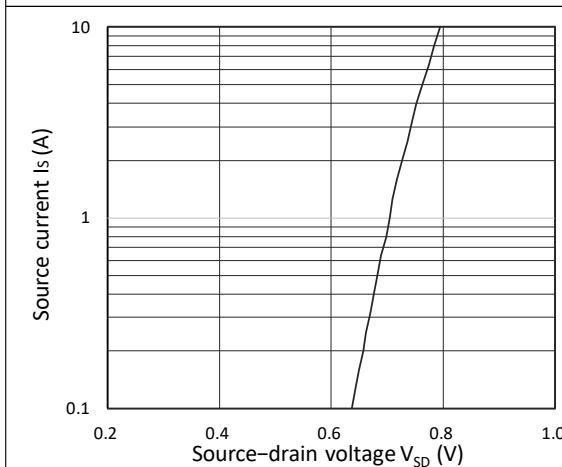
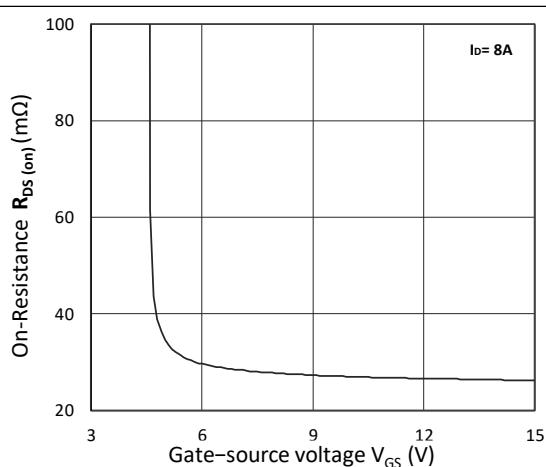
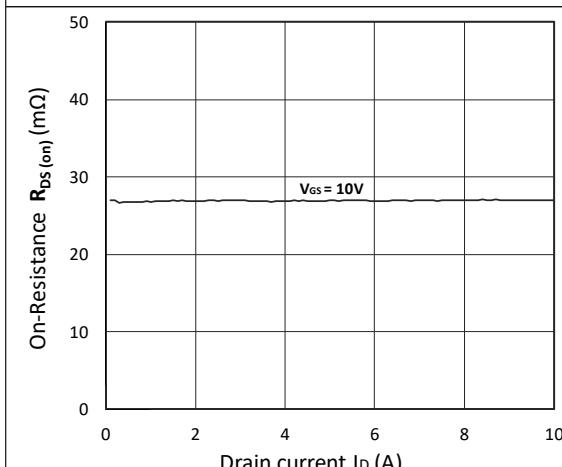
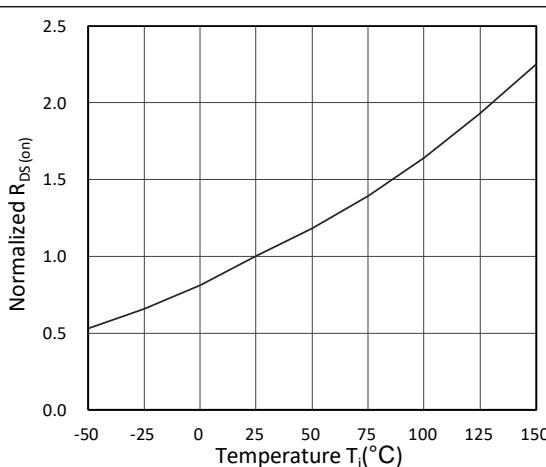


Figure 3. Forward Characteristics of Reverse

Figure 4. $R_{DS(\text{on})}$ vs. V_{GS} Figure 5. $R_{DS(\text{on})}$ vs. I_D Figure 6. Normalized $R_{DS(\text{on})}$ vs. Temperature

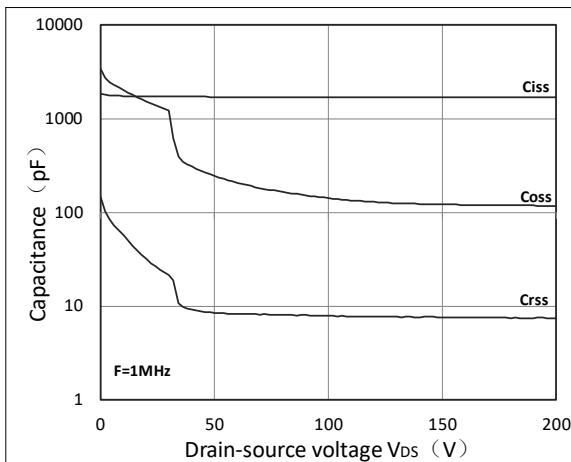


Figure 7. Capacitance Characteristics

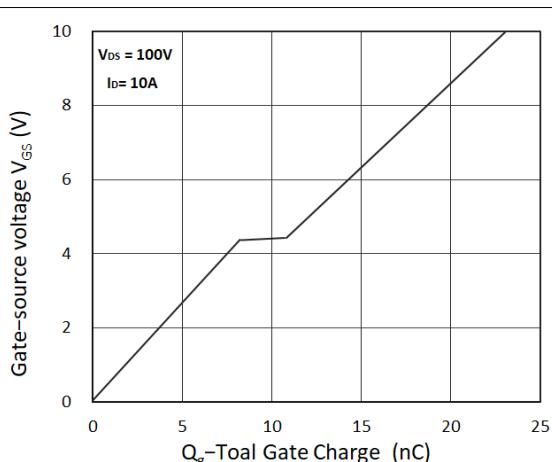


Figure 8. Gate Charge Characteristics

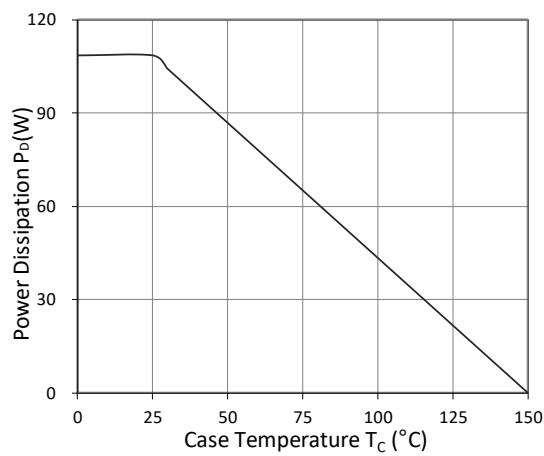


Figure 9. Power Dissipation

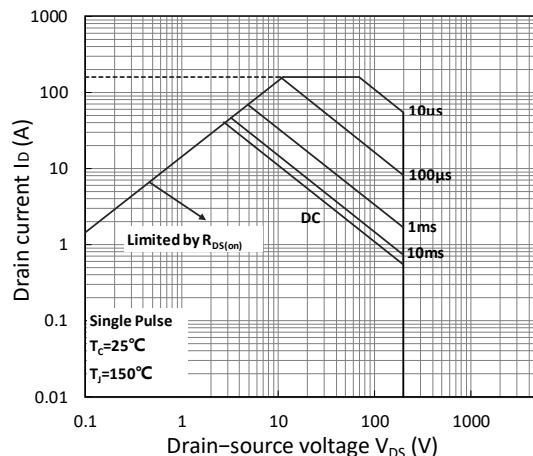


Figure 10. Safe Operating Area

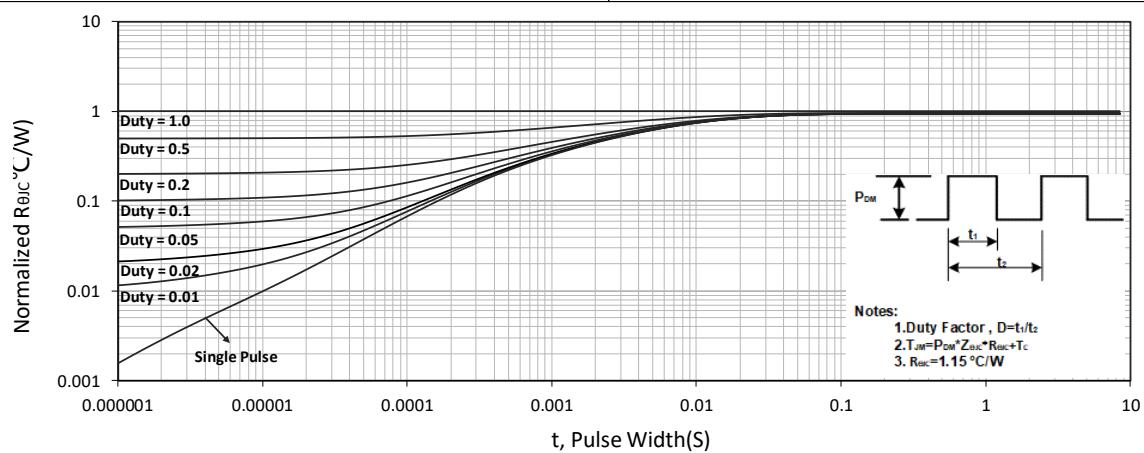
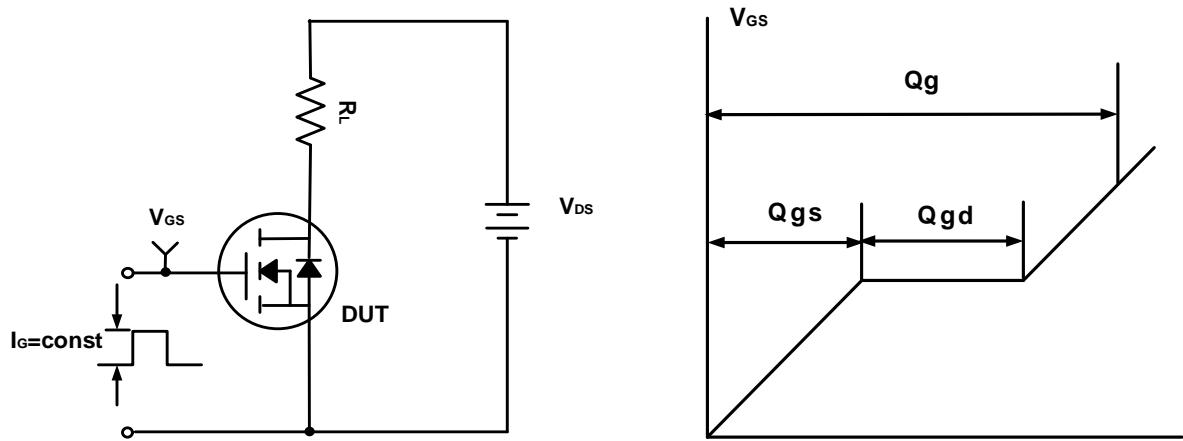
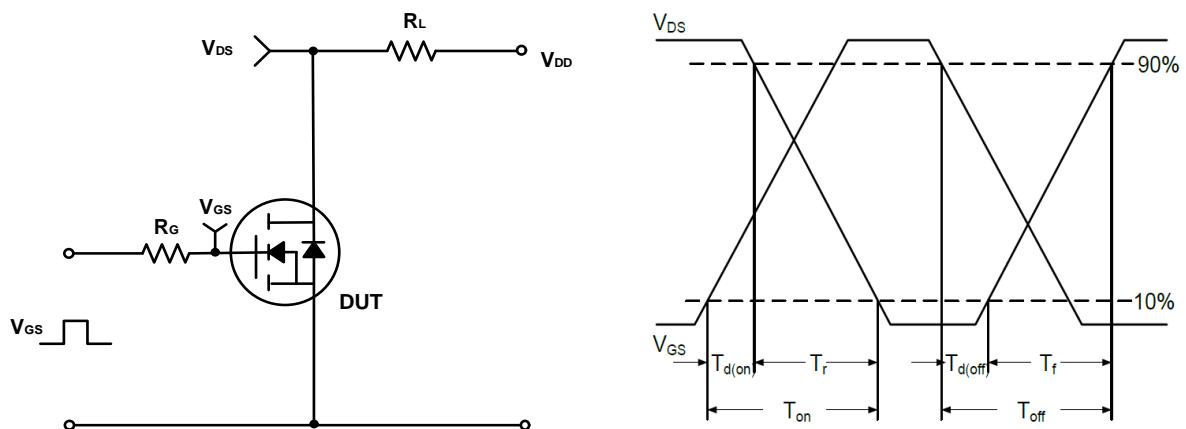
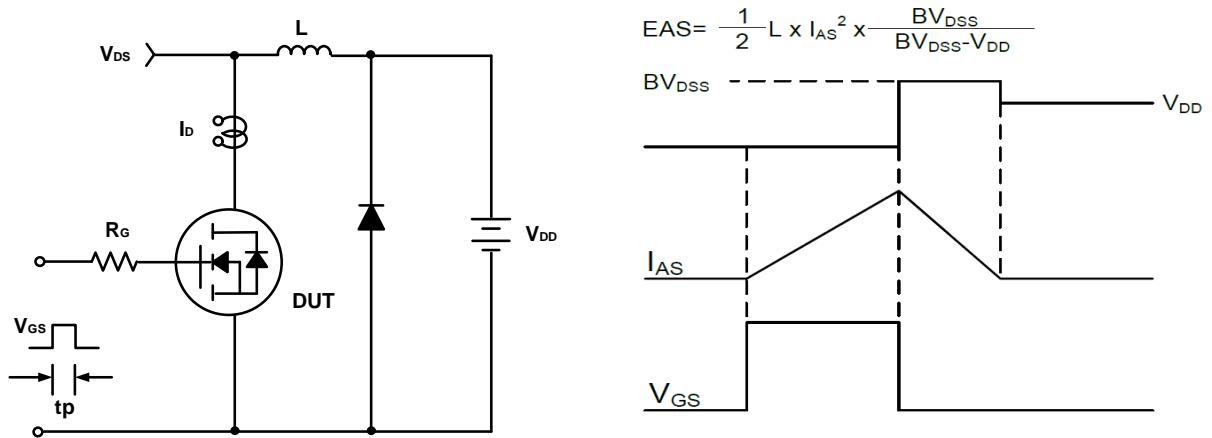
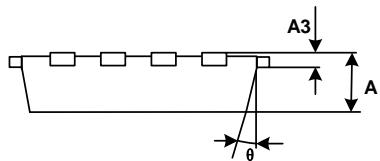
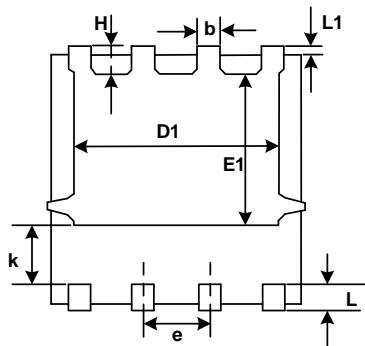
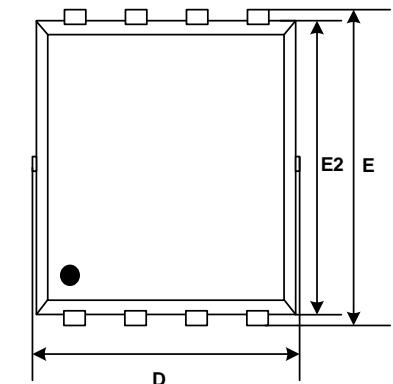


Figure 11. Normalized Maximum Transient Thermal Impedance

Test Circuit**Figure A. Gate Charge Test Circuit & Waveforms****Figure B. Switching Test Circuit & Waveforms****Figure C. Unclamped Inductive Switching Circuit & Waveforms**

Mechanical Dimensions for PDFN5060-8L

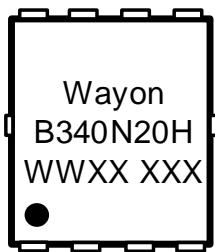
COMMON DIMENSIONS



SYMBOL	MM	
	MIN	MAX
A	0.90	1.20
A3	0.15	0.35
D	4.80	5.40
E	5.90	6.35
D1	3.61	4.31
E1	3.30	3.92
E2	5.50	6.06
k	1.10	-
b	0.30	0.51
e	1.27BSC	
L	0.38	0.71
L1	0.05	0.36
H	0.38	0.71
θ	0°	12°

Ordering Information

Part	Package	Marking	Packing method
WMB340N20HG2	PDFN5060-8L	B340N20H	Tape and Reel

Marking Information

B340N20H = Device code

WWXX XXX= Date code

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